

<b>Notice of References Cited</b>	Application/Control No. 10/649,943		Applicant(s)/Patent Under Reexamination CHEN, CHRIS	
	Examiner Xiuqin Sun		Art Unit 2863	Page 1 of 1

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*	B	US-2004/0080614 A1	04-2004	Uemura, Yoshiyuki	348/096
*	C	US-2003/0117711 A1	06-2003	Kowarz et al.	359/618
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	K	US-			
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**NON-PATENT DOCUMENTS**

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